

IGBT - Field Stop 600 V, 40 A

FGH40N60SMD-F085

Description

Using Novel Field Stop IGBT Technology, ON Semiconductor's new series of Field Stop IGBTs offer the optimum performance for Automotive Chargers, Inverter, and other applications where low conduction and switching losses are essential.

Features

- Maximum Junction Temperature: $T_J = 175^\circ\text{C}$
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(sat)} = 1.9\text{ V(Typ.) @ } I_C = 40\text{ A}$
- High Input Impedance
- Tightened Parameter Distribution
- AEC Qualified and PPAP Capable
IGBT: AEC-Q101
- This Device is Pb-Free and is RoHS Compliant

Applications

- Automotive Chargers, Converters, High Voltage Auxiliaries
- Inverters, SMPS, PFC, UPS

ABSOLUTE MAXIMUM RATINGS

| Rating | Symbol | Ratings | Unit |
|--|----------------------|-------------|------------------|
| Collector to Emitter Voltage | V_{CES} | 600 | V |
| Gate to Emitter Voltage | V_{GES} | ± 20 | V |
| Collector Current @ $T_c = 25^\circ\text{C}$ @ $T_c = 100^\circ\text{C}$ | I_C | 80 40 | A |
| Pulsed Collector Current | I_{CM} (Note 1) | 120 | A |
| Diode Forward Current @ $T_c = 25^\circ\text{C}$ @ $T_c = 100^\circ\text{C}$ | I_F | 40 20 | A |
| Pulsed Diode Maximum Forward Current | I_{FM} (Note 1) | 120 | A |
| Maximum Power Dissipation @ $T_c = 25^\circ\text{C}$ @ $T_c = 100^\circ\text{C}$ | P_D | 349 174 | W |
| Operating Junction Temperature | T_J | -55 to +175 | $^\circ\text{C}$ |
| Storage Temperature Range | T_{stg} | -55 to +175 | $^\circ\text{C}$ |
| Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds | T_L | 300 | $^\circ\text{C}$ |

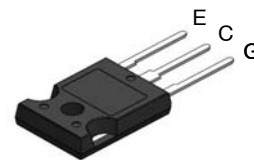
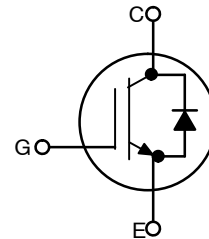
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Repetitive rating: Pulse width limited by max. junction temperature.



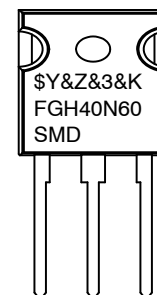
ON Semiconductor®

www.onsemi.com



TO-247-3LD
CASE 340CK

MARKING DIAGRAM



$\$Y$ = ON Semiconductor Logo
 $\&Z$ = Assembly Plant Code
 $\&3$ = Numeric Date Code
 $\&K$ = Lot Code
 FGH40N60SMD = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

FGH40N60SMD-F085

THEMAL CHARACTERISTICS

| Parameter | Symbol | Rated | Unit |
|---|--------------------------|-------|---------------|
| Thermal Resistance Junction-to-Case, for IGBT | $R_{\theta JC}$ (Note 2) | 0.43 | $^{\circ}C/W$ |
| Thermal Resistance Junction-to-Case, for Diode | $R_{\theta JC}$ | 1.8 | $^{\circ}C/W$ |
| Parameter | Symbol | Typ. | |
| Thermal Resistance Junction-to-Ambient (PCB Mount) (Note 2) | $R_{\theta JA}$ | 45 | $^{\circ}C/W$ |

2. $R_{\theta JC}$ for TO-247: according to Mil standard 883-1012 test method. $R_{\theta JA}$ for TO-247: according to JESD51-2, test method environmental condition and JESD51-10, test boards for through hole perimeter leaded package thermal measurements. JESD51-3: Low Effective Thermal Conductivity Test Board for Leaded Surface Mount Package.

PACKAGE MARKING AND ORDERING INFORMATION

| Device Marking | Device | Package | Package Type | Quantity |
|----------------|------------------|----------|--------------|----------|
| FGH40N60SMD | FGH40N60SMD-F085 | TO-247-3 | Tube | 30 Units |

ELECTRICAL CHARACTERISTICS OF THE IGBT ($T_C = 25^{\circ}C$ unless otherwise noted)

| Parameter | Symbol | Test Conditions | Min | Typ | Max | Unit |
|-----------|--------|-----------------|-----|-----|-----|------|
|-----------|--------|-----------------|-----|-----|-----|------|

OFF CHARACTERISTICS

| | | | | | | |
|--|------------------------------|---|-----|-----|-----------|---------------|
| Collector to Emitter Breakdown Voltage | BV_{CES} | $V_{GE} = 0 V, I_C = 250 \mu A$ | 600 | - | - | V |
| Temperature Coefficient of Breakdown Voltage | $\Delta BV_{CES}/\Delta T_J$ | $V_{GE} = 0 V, I_C = 250 \mu A$ | - | 0.6 | - | $V/^{\circ}C$ |
| Collector Cut-Off Current | I_{CES} | $V_{CE} = V_{CES}, V_{GE} = 0 V$ | - | - | 250 | μA |
| | | I_{CES} at 80% * $BV_{CES}, 175^{\circ}C$ | - | - | 800 | |
| G-E Leakage Current | I_{GES} | $V_{GE} = V_{GES}, V_{CE} = 0 V$ | - | - | ± 400 | nA |

ON CHARACTERISTICS

| | | | | | | |
|---|---------------|---|-----|-----|-----|---|
| G-E Threshold Voltage | $V_{GE(th)}$ | $I_C = 250 \mu A, V_{CE} = V_{GE}$ | 3.5 | 4.5 | 6.0 | V |
| Collector to Emitter Saturation Voltage | $V_{CE(sat)}$ | $I_C = 40 A, V_{GE} = 15 V$ | - | 1.9 | 2.5 | V |
| | | $I_C = 40 A, V_{GE} = 15 V, T_C = 175^{\circ}C$ | - | 2.1 | - | V |

DYNAMIC CHARACTERISTICS

| | | | | | | |
|------------------------------|-----------|--|---|------|------|----|
| Input Capacitance | C_{ies} | $V_{CE} = 30 V, V_{GE} = 0 V, f = 1 MHz$ | - | 1880 | 2500 | pF |
| Output Capacitance | C_{oes} | | - | 180 | 240 | pF |
| Reverse Transfer Capacitance | C_{res} | | - | 50 | 65 | pF |

SWITCHING CHARACTERISTICS

| | | | | | | |
|-------------------------|--------------|--|---|------|------|----|
| Turn-On Delay Time | $t_{d(on)}$ | $V_{CC} = 400 V, I_C = 40 A, R_G = 6 \Omega, V_{GE} = 15 V, \text{Inductive Load}, T_C = 25^{\circ}C$ | - | 18 | 24 | ns |
| Rise Time | t_r | | - | 28 | 36.4 | ns |
| Turn-Off Delay Time | $t_{d(off)}$ | | - | 110 | 143 | ns |
| Fall Time | t_f | | - | 13.2 | 18.5 | ns |
| Turn-On Switching Loss | E_{on} | | - | 0.92 | 1.2 | mJ |
| Turn-Off Switching Loss | E_{off} | | - | 0.3 | 0.39 | mJ |
| Total Switching Loss | E_{ts} | | - | 1.22 | 1.59 | mJ |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{CC} = 400 V, I_C = 40 A, R_G = 6 \Omega, V_{GE} = 15 V, \text{Inductive Load}, T_C = 175^{\circ}C$ | - | 16.7 | 23.8 | ns |
| Rise Time | t_r | | - | 27 | 35.1 | ns |
| Turn-Off Delay Time | $t_{d(off)}$ | | - | 116 | 151 | ns |
| Fall Time | t_f | | - | 56.5 | 81 | ns |
| Turn-On Switching Loss | E_{on} | | - | 1.47 | 1.91 | mJ |
| Turn-Off Switching Loss | E_{off} | | - | 0.73 | 0.95 | mJ |
| Total Switching Loss | E_{ts} | | - | 2.20 | 2.86 | mJ |

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ELECTRICAL CHARACTERISTICS OF THE IGBT ($T_C = 25^\circ\text{C}$ unless otherwise noted) (continued)

| Parameter | Symbol | Test Conditions | Min | Typ | Max | Unit |
|--------------------------|----------|--|-----|-----|-----|------|
| Total Gate Charge | Q_g | $V_{CE} = 400\text{ V}, I_C = 40\text{ A}, V_{GE} = 15\text{ V}$ | - | 119 | 180 | nC |
| Gate to Emitter Charge | Q_{ge} | | - | 13 | 20 | nC |
| Gate to Collector Charge | Q_{gc} | | - | 58 | 90 | nC |

ELECTRICAL CHARACTERISTICS OF THE DIODE ($T_J = 25^\circ\text{C}$ unless otherwise noted)

| Parameter | Symbol | Test Conditions | Min | Typ | Max | Unit | |
|-------------------------------|-----------|---|---------------------------|-----|------|------|---------------|
| Diode Forward Voltage | V_{FM} | $I_F = 20\text{ A}$ | $T_C = 25^\circ\text{C}$ | - | 2.3 | 2.8 | V |
| | | | $T_C = 175^\circ\text{C}$ | - | 1.67 | - | |
| Reverse Recovery Energy | E_{rec} | $I_F = 20\text{ A}, di_F/dt = 200\text{ A}/\mu\text{s}$ | $T_C = 175^\circ\text{C}$ | - | 48.9 | - | μJ |
| Diode Reverse Recovery Time | t_{rr} | | $T_C = 25^\circ\text{C}$ | - | 36 | 47 | ns |
| | | | $T_C = 175^\circ\text{C}$ | - | 110 | - | |
| Diode Reverse Recovery Charge | Q_{rr} | | $T_C = 25^\circ\text{C}$ | - | 46.8 | 61 | nC |
| | | $T_C = 175^\circ\text{C}$ | - | 470 | - | | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

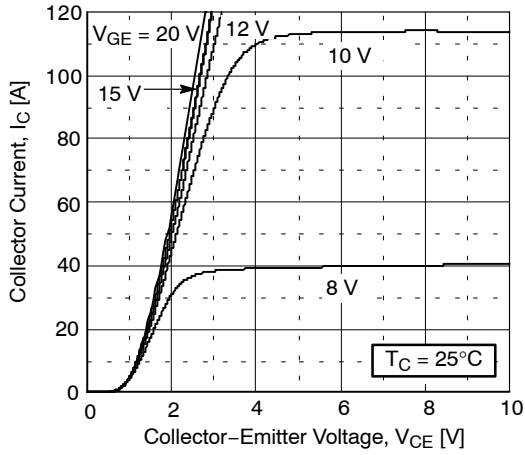


Figure 1. Typical Output Characteristics

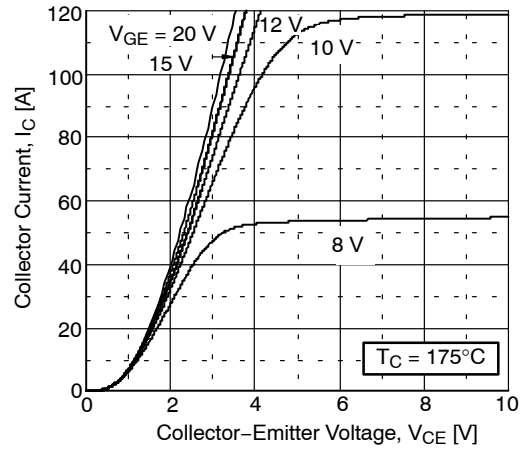


Figure 2. Typical Output Characteristics

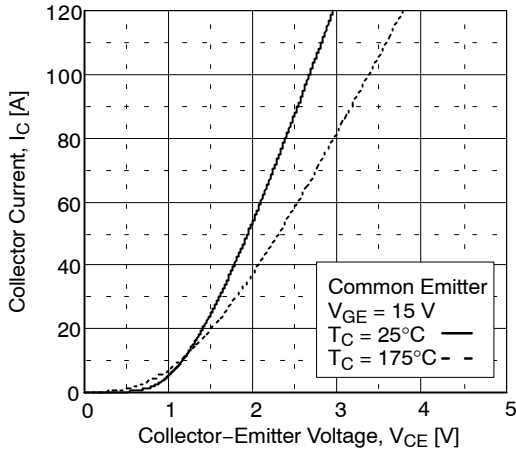


Figure 3. Typical Saturation Voltage Characteristics

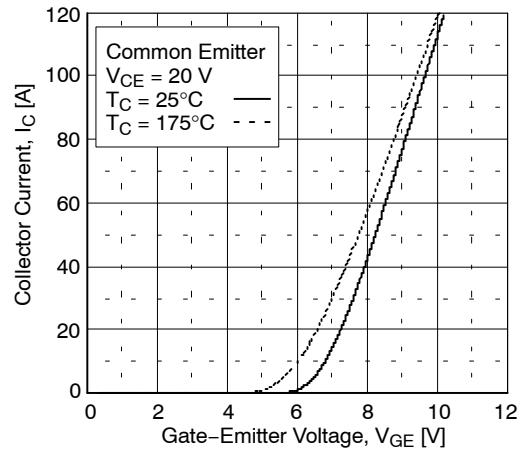


Figure 4. Transfer Characteristics

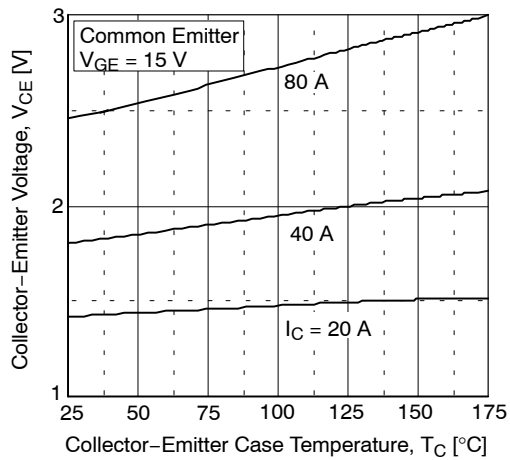


Figure 5. Saturation Voltage vs. Case Temperature at Variant Current Level

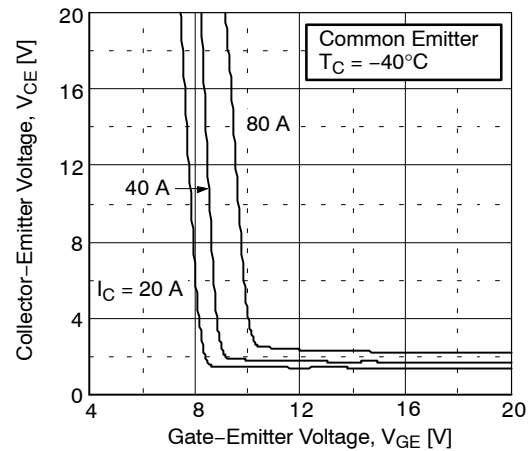


Figure 6. Saturation Voltage vs. V_{GE}

TYPICAL CHARACTERISTICS

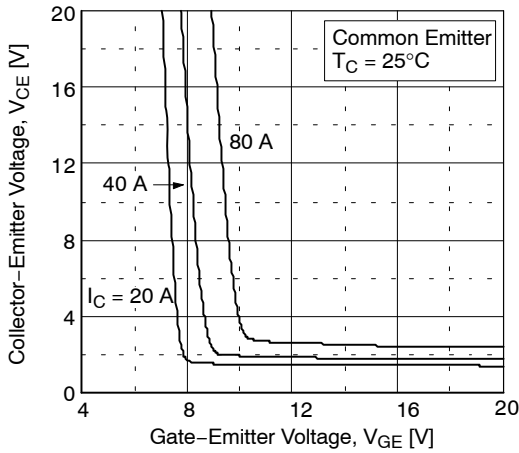


Figure 7. Saturation Voltage vs. V_{GE}

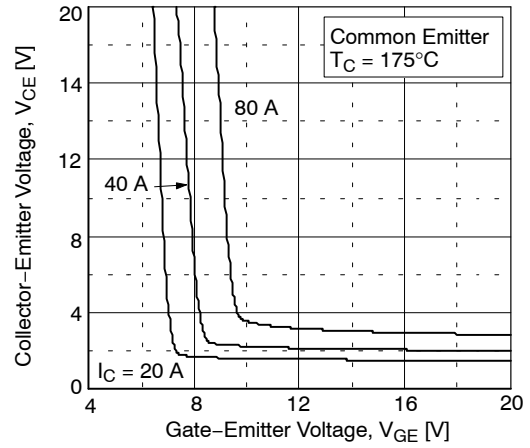


Figure 8. Saturation Voltage vs. V_{GE}

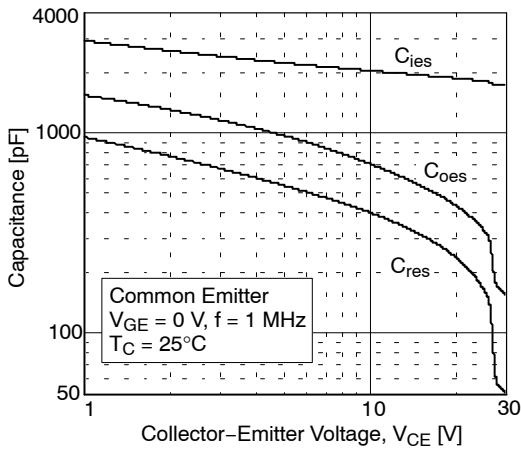


Figure 9. Capacitance Characteristics

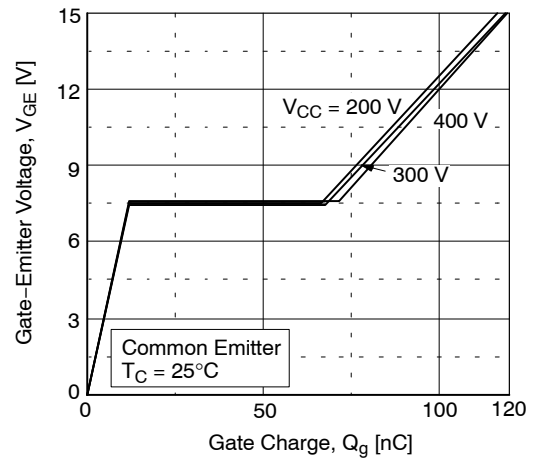


Figure 10. Gate Charge Characteristics

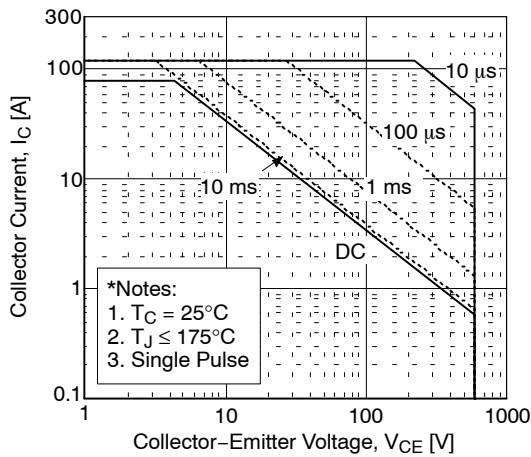


Figure 11. SOA Characteristics

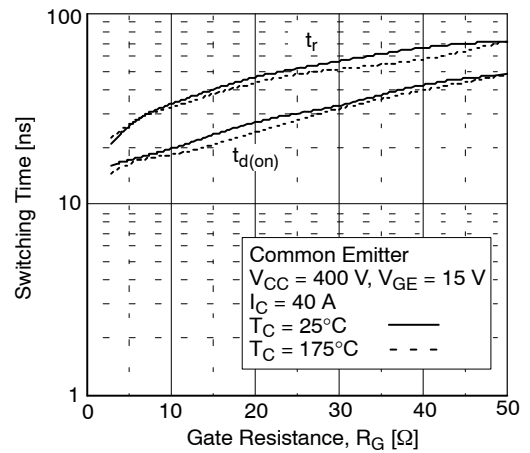


Figure 12. Turn-on Characteristics vs. Gate Resistance

TYPICAL CHARACTERISTICS

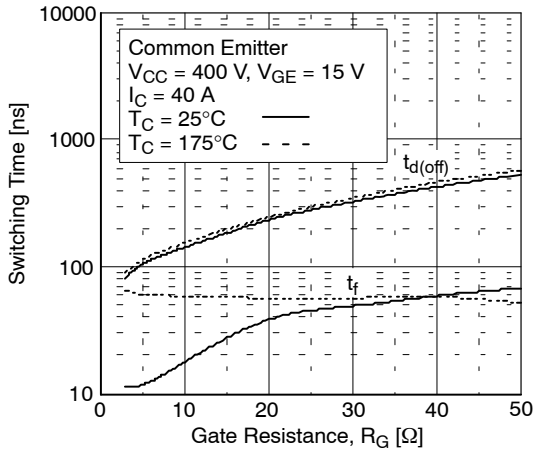


Figure 13. Turn-off Characteristics vs. Gate Resistance

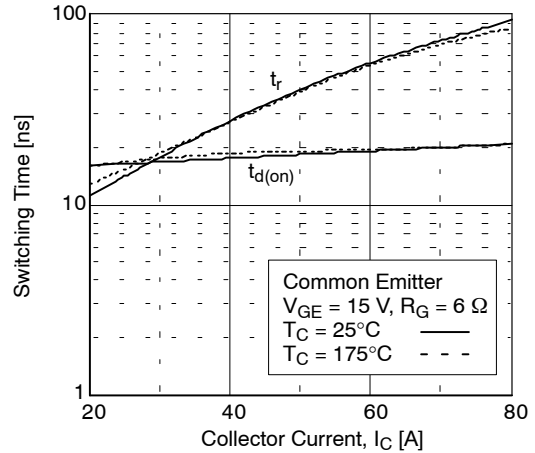


Figure 14. Turn-on Characteristics vs. Collector Current

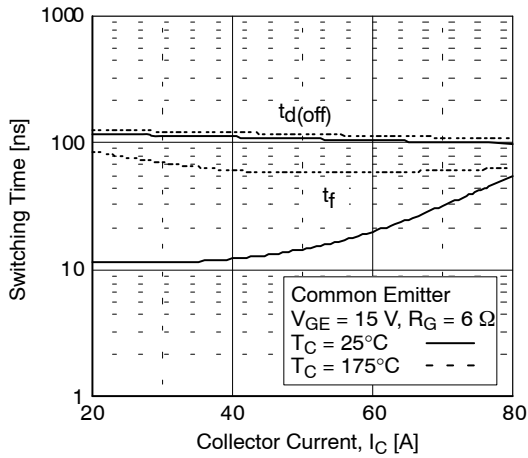


Figure 15. Turn-off Characteristics vs. Collector Current

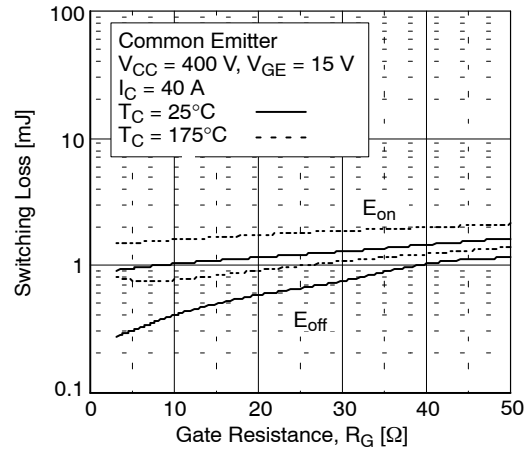


Figure 16. Switching Loss vs. Gate Resistance

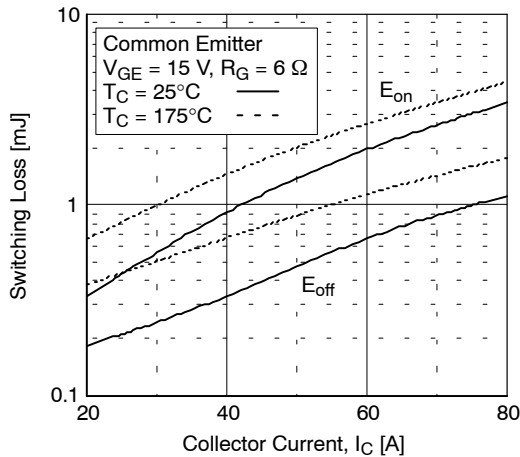


Figure 17. Switching Loss vs. Collector Current

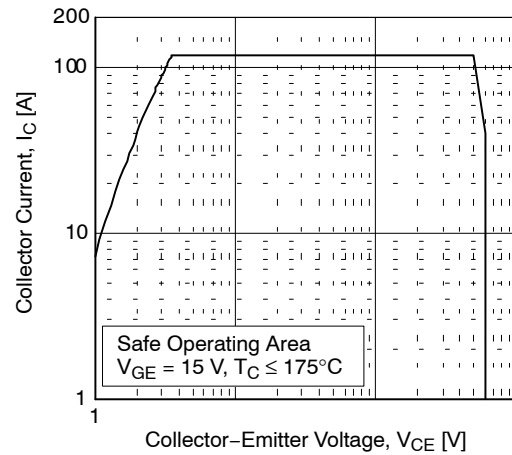


Figure 18. Turn-off Switching SOA Characteristics

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TYPICAL CHARACTERISTICS

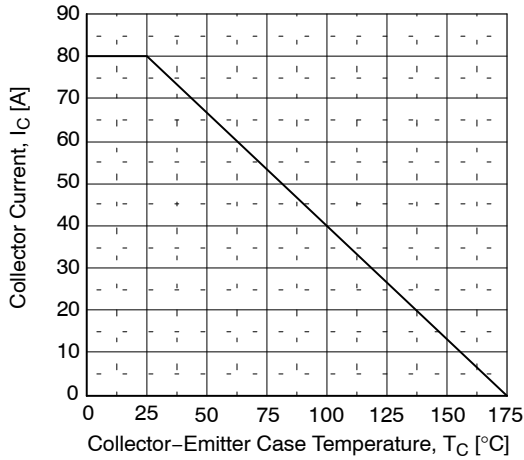


Figure 19. Current Derating

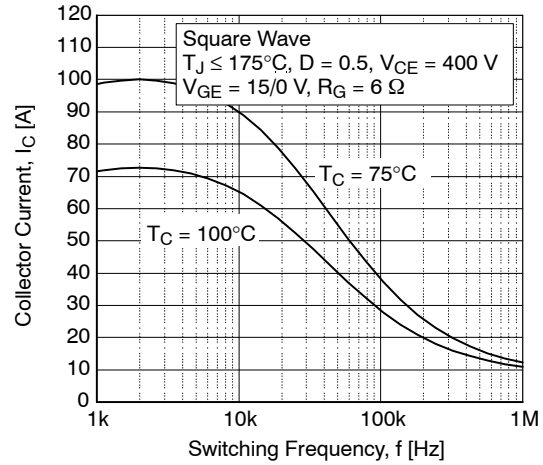


Figure 20. Load Current vs. Frequency

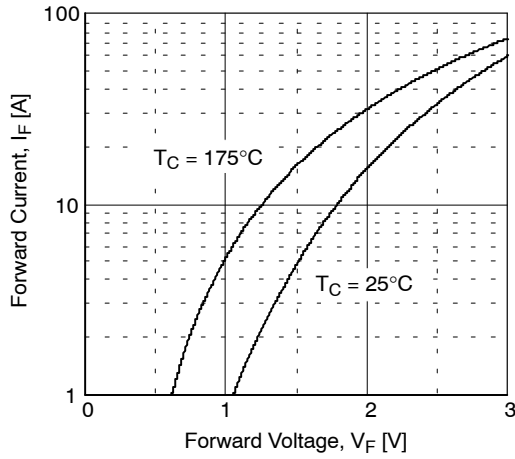


Figure 21. Forward Characteristics

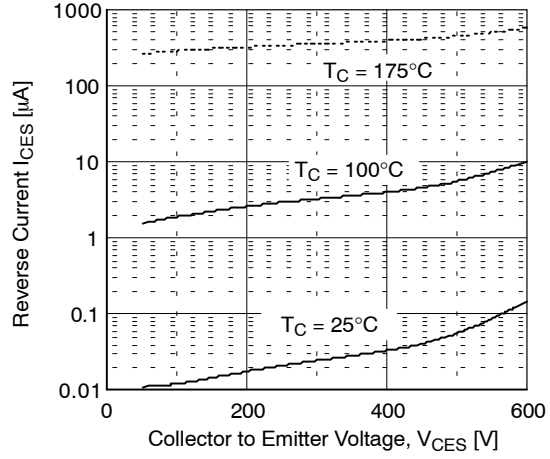


Figure 22. Reverse Current

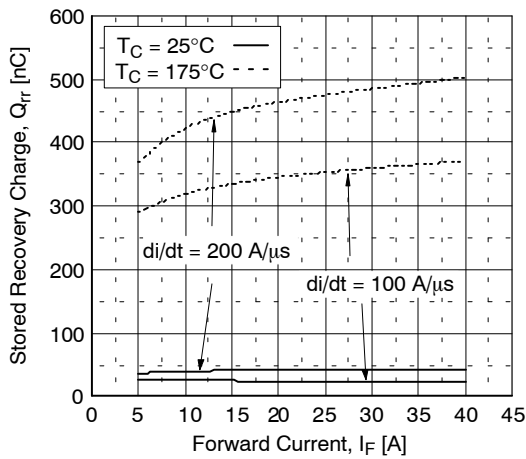


Figure 23. Stored Charge

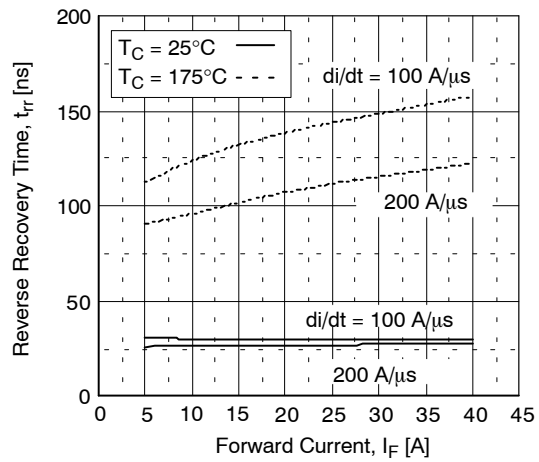


Figure 24. Reverse Recovery Time

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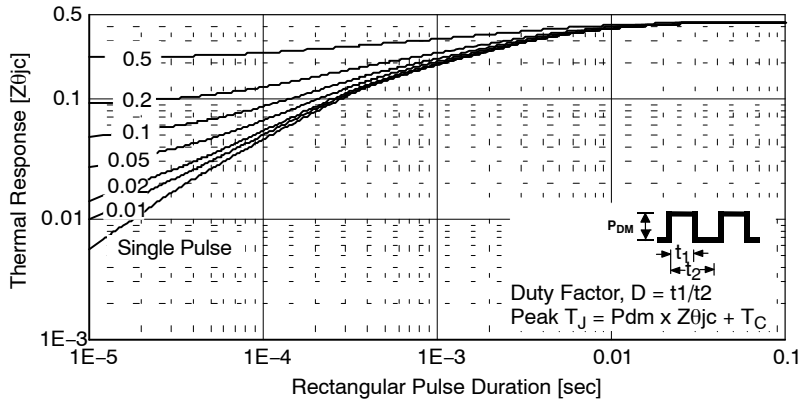


Figure 25. Transient Thermal Impedance of IGBT

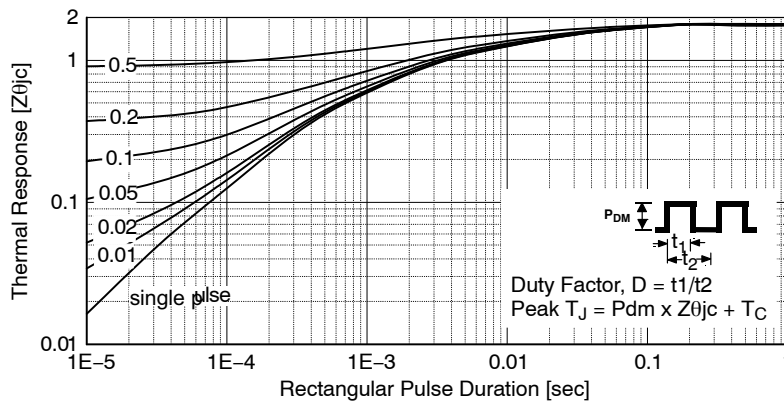


Figure 26. Transient Thermal Impedance of Diode



TO-247-3LD SHORT LEAD
CASE 340CK
ISSUE A

DATE 31 JAN 2019



NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 - 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



- XXXX = Specific Device Code
- A = Assembly Location
- Y = Year
- WW = Work Week
- ZZ = Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

| DIM | MILLIMETERS | | |
|-----|-------------|-------|-------|
| | MIN | NOM | MAX |
| A | 4.58 | 4.70 | 4.82 |
| A1 | 2.20 | 2.40 | 2.60 |
| A2 | 1.40 | 1.50 | 1.60 |
| b | 1.17 | 1.26 | 1.35 |
| b2 | 1.53 | 1.65 | 1.77 |
| b4 | 2.42 | 2.54 | 2.66 |
| c | 0.51 | 0.61 | 0.71 |
| D | 20.32 | 20.57 | 20.82 |
| D1 | 13.08 | ~ | ~ |
| D2 | 0.51 | 0.93 | 1.35 |
| E | 15.37 | 15.62 | 15.87 |
| E1 | 12.81 | ~ | ~ |
| E2 | 4.96 | 5.08 | 5.20 |
| e | ~ | 5.56 | ~ |
| L | 15.75 | 16.00 | 16.25 |
| L1 | 3.69 | 3.81 | 3.93 |
| ØP | 3.51 | 3.58 | 3.65 |
| ØP1 | 6.60 | 6.80 | 7.00 |
| Q | 5.34 | 5.46 | 5.58 |
| S | 5.34 | 5.46 | 5.58 |

| | | |
|-------------------------|-----------------------|--|
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